
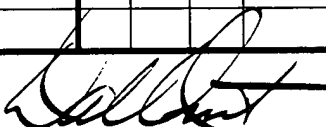


Issue Classification 	Application/Control No. 10/605,517	Applicant(s)/Patent under Reexamination LIEN, CHI-CHIN
	Examiner Jean W. Désir	Art Unit 2622

ISSUE CLASSIFICATION												
ORIGINAL					INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS			CLAIMED					NON-CLAIMED		
348		448			H	04	N	7	/01			
CROSS REFERENCES					H	04	N	7	/46			
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											
348	452	430.1	715					/			/	
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Jean W. Désir, 1/31/08 (Assistant Examiner) (Date)					 DAVID OMETZ SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 1/31/08					Total Claims Allowed: 15		
(Legal Instruments Examiner) (Date)					O.G. Print Claim(s) 5					O.G. Print Fig. 2		

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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